CE EMC TEST REPORT

according to

EN 301 489-1 V1.4.1 (2002-08) and EN 301 489-17 V1.2.1 (2002-08)

Applicant	TRENDware International, Inc.	
Address	3135 Kashiwa Street, Torrance, CA90505 U.S.A.	
Equipment	Cable/DSL 802.11g 54Mbps Wireless Router	
Model No.	TEW-431BRP	
Trade Name	TRENDware	
Power Supply Type	AC Adaptor: Model: MW48-1201000U, I/P: 230Vac/50Hz; O/P: 12Vdc, 800mA	

- The test result refers exclusively to the test presented test model / sample.
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- This test report is only applicable to European Community.

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CERTIFICATE OF COMPLIANCE

according to

EN 301 489-1 V1.4.1 (2002-08) and EN 301 489-17 V1.2.1 (2002-08)

Applicant	TRENDware International, Inc.	
Address	3135 Kashiwa Street, Torrance, CA90505 U.S.A.	
Equipment	Cable/DSL 802.11g 54Mbps Wireless Router	
Model No.	TEW-431BRP	

I HEREBY CERTIFY THAT:

The measurements shown in this test report were made in accordance with the procedures given in EUROPEAN COUNCIL DIRECTIVE 99/5/EC. The equipment was *passed* the test performed according to EN 301 489-1 V1.4.1 (2002-08) and EN 301 489-17 V1.2.1 (2002-08). The test was carried out on Nov. 28, 2003 at Electronics Testing Center, Taiwan.

Anson Chou / Manager

1. Definition

Unintentional radiator:

A device that intentionally generates and radio frequency energy for use within the device, or that sends radio frequency signals by conduction to associated equipment via connecting wiring, but which is not intended to emit RF energy by radiation or induction.

Class A Digital Device:

A digital device Which is marketed for use in commercial or business environment; exclusive of a device which is market for use by the general public, or which is intended to be used in the home.

Class B Digital Device:

A digital device which is marketed for use in a residential environment notwithstanding use in a commercial, business of industrial environment. Example of such devices that are marketed for the general public.

Note:

A manufacturer may also qualify a device intended to be marketed in a commercial, business, or industrial environment as a Class B digital device, and in fact is encouraged to do so, In the event that a particular type of device has been found to repeatedly cause harmful interference to radio communications, the Commission may classify such a digital device as a Class B Digital Device, Regardless of its intended use.

Intentional radiator:

A device that intentionally generates and emits radio frequency energy by radiation or induction.

I ssued date: Dec. 16, 2003

2. Test Distance

- a. The test distance of radiated emission test from antenna to EUT is 10 M.
- b. The test distance of radio frequency electromagnetic field immunity test from antenna to EUT is 3 M.

2.1. Summary of Test Results

19.1.1Emission Tests

Measurement	Reference Clause(s)	Test	Reference standard
Radiated emission	8.2	PASSED	EN 55022/A1:2000 class B
Conducted emission	8.3/8.4	PASSED	EN 55022/A1:2000 class B
Harmonic current emissions	8.5	N/A	EN 61000-3-2:2000
Voltage fluctuations and flicker	8.6	PASSED	EN 61000-3-3:1995

19.1.2Immunity Tests

Measurement	Reference Clause(s)	Test	Reference standard
Electrostatic	9.3	PASSED	EN 61000-4-2:1995/A1:1998
discharge	9.5	TAGGED	EN 01000-4-2.1993/A1.1998
RF electro-magnetic			
Field (80-1000 MHz,	9.2	PASSED	EN 61000-4-3:1996/A1:1998
1400-2000 MHz.)			
Fast transients	9.4	PASSED	EN 61000-4-4:1995
common mode	9.4	TAGGED	EN 81000-4-4.1995
Surge	9.8	PASSED	EN 61000-4-5:1995
Radio frequency,	0.5	PASSED	EN 64000 4 6:4006
common mode	9.5	PASSED	EN 61000-4-6:1996
Voltage dips and	9.7	PASSED	EN 61000-4-11:1994
interrupts	9.7	FAGGED	EN 61000-4-11:1994

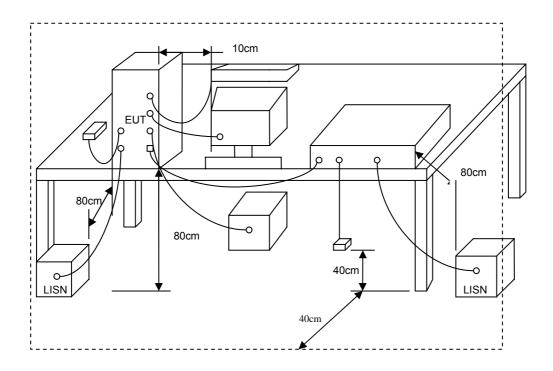
3. Test of Conducted Powerline

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 301 489-17. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meters above the ground plane as shown in section 2.2. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

3.1. Test Procedures

- a. The EUT was placed on a desk 0.8 meters height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meters from any other grounded conducting surface.
- b. Connect EUT to the power mains through a line impedance stabilization network (LISN).
- c. All the support units are connect to the other LISN.
- d. The LISN provides 50 ohm coupling impedance for the measuring instrument.
- e. The CISPR states that a 50 ohm , 50 microhenry LISN should be used.
- f. Both sides of AC line were checked for maximum conducted interference.
- g. The frequency range from 150 kHz to 30 MHz was searched
- h. Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.





3.3. Conducted Emission Requirement

The equipment under test EUT) shall meet the limits in table 1 and 3 or 2 and 4, as applicable, including the average limit and the quasi-peak limit when using, repectively, an average detector receiver and quasi-peak detector receiver and measured in accordance with the methods described in clause 9. Either the voltage limits or the current limits in table 3 or 4, as applicable, shall be met except for the measurement method of C.1.3 where both limits shall be met. If the average limit is met when using a qusai-peak decetor reciver, the EUT shall be deemeed to meet both limits and measurement with the average detector receiver is unnecessary.

If the reading of the measuring receiver shows fluctuations close to the limit, the reading shall be observed for at least 15 s at each measurement frequency, the higher reading shall be recorded with the exception of any brief isolated hith reading which shall be ignored.

Frequency range	Limits (dB μ V)	
(MHz)	Quasi Peak	Average
0.15 to0.50	66 to 56*	56 to 46*
0.50 to5	56	46
5. to 30.	60	50

NOTE 1-The lower limits shall apply at the transition frequencies. NOTE 2-The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHZ to 0.50MHZ.

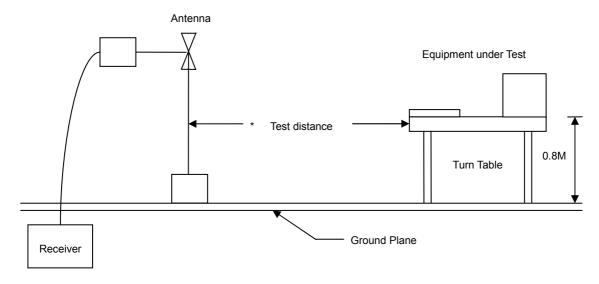
4. Test of Radiated Emission

Radiated emissions from 30 MHz to 1000 MHz were measured with a bandwidth of 120 kHz according to the methods defines in European Standard EN 301 489-17. The EUT was placed on a nonmetallic stand in the open-field site, 0.8 meter above the ground plane, as shown in section 3.2. The interface cables and equipment positions were varied within limits of reasonable applications to determine the positions producing maximum radiated emissions.

4.1. Test Procedures

- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
- b. The EUT was set 10 meters from the interference receiving antenna which was mounted on the top of a variable height antenna tower.
- c. The table was rotated 360 degrees to determine the position of the highest radiation.
- d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- g. If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.

4.2. Typical Test Setup Layout of Radiated Emission



4.3. Radiated Emission Requirement

The EUT shall meet limits of tables as below when measured at the measuring distance R in accordance with the methods described in clause 10. If the reading on the measuring receiver shows fluctuations close to the limit, the reading shall be observed for at least 15 s at each isolated high reading, which shall be ignored.

Limit for radiated disturbance of class B ITE at a measuring distance of 10 m

Frequency	Quasi-peak limits
(MHz)	dB (uV/m)
30 to 230	30
230 to 1000	37

Note 1- The lower limit shall apply at the transition frequency.

2- Additional provisions may be required for cases where interference occurs.

5. Harmonics Test

5.1. STANDARD

Product Standard : EN 61000-3-2:2000

5.2. Test Procedure

As specified on clause 7 and figure Z1 of EN 61000-3-2:2000, the limits are not specified for equipment with a rated power of 75W or less.

The EUT meets the above condition, so it conforms to EN 61000-3-2.

6. Voltage Fluctuations Test

6.1. **STANDARD**

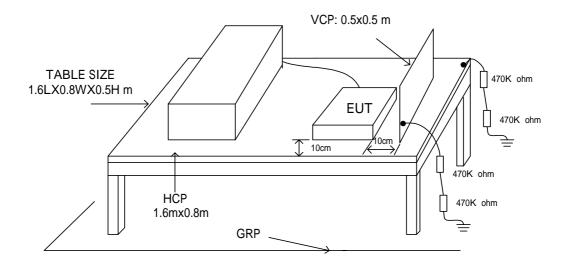
Product Standard : EN 61000-3-3:1995/A1:2001

6.2. Test Procedure

The equipment shall be tested under the conditions of Clause 5.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of $\pm 8\%$ is achieved during the whole assessment procedure.

7. Test setup (ESD)



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner:

- a. CONTACT DISCHARGE to the conductive surfaces and to coupling plane;
- b. AIR DISCHARGE at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

7.1. Test Setup for Tests Performed in Laboratory

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the ELECTRONICS TESTING CENTER., we provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1m minimum was provided between the EUT and the wall of the lab. and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resister located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8m high, standing on the ground reference plane. A HCP, 1.6 m x 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, $0.5 \text{ m} \times 0.5 \text{ m}$.

7.2. Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
 - ambient temperature: 15 to 35;
 - relative humidity: 30% to 60%;
 - atmospheric pressure: 68 KPa (680 mbar) to 106 KPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On preselected points at least 25 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
 - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
 - ♦ Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
 - ♦ The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

8. Test Procedure (RS)

- a. The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- b. The antenna which is enabling the complete frequency range of 80-1000MHz; 1400-2000 MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- c. The test is normally performed with the antenna facing the most sensitive side of the EUT. The polarization of the field generated by the biconical antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally. The circular polarization of the field from the log-spiral antenna makes a change of position of the antenna unnecessary.
- d. At each of the above conditions, the frequency range is swept 80-1000 MHz; 1400-2000 MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of 1.5*10-3 decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

9. Test on Power Line (EFT)

- a. The EFT/B-generator was located on the GRP. The length from the EFT/B-generator to the EUT as not exceed 1 m.
- b. The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT..

9.1. Test on Communication Lines

- a. The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
- b. The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.

9.2. Test Procedure

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:

 - → relative humidity: 45% to 75%;
 - atmospheric pressure: 68 Kpa (680 mbar) to 106 Kpa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria:
 - Normal performance within the specification limits.
 - ♦ Temporary degradation or loss of function or performance which is self-recoverable.
 - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
 - Degradation or loss of function which is not recoverable due to damage of equipment (components).

10. Test Procedure (Surge)

a. Climatic conditions

The climatic conditions shall comply with the following requirements :

ambient temperature: 15 to 35
 relative humidity: 10 % to 75 %

b. Electromagnetic conditions

the electromagnetic environment of the laboratory shall not influence the test results.

- c. The test shall be performed according the test plan that shall specify the test set-up with

 - test level (voltage/current);

 - ♦ internal or external generator trigger;
 - number of tests: at least five positive and five negative at the selected points;

 - inputs and outputs to be tested;
 - representative operating conditions of the EUT;
 - ♦ sequence of application of the surge to the circuit;
 - phase angle in the case of a.c. power supply;

AC: neutral earthed,

DC: (+) or (-) earthed to simulated the actual earthing conditions.

- d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave (positive and negative).
- e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.
- f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.
- g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worstcase voltage breakdown level (let-through level) of the primary protection.
- h. If the actual operating signal sources are not available, the may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according the a test plan.
- i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test a previously unstressed equipment shall be used to the protection devices shall be replaced.

11. Test Procedure (CS)

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. The frequency range is swept from 150 KHz to 230 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1KHz sinewave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5 x 10⁻³ decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- e. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- f. An alternative test procedure may be adopted, wherein the frequency range is swept incrementally, with a step size not exceeding 4% of the start ad thereafter 4% of the preceding frequency value.
 The test level should be at least twice the value of the specified test level.
- g. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- h. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- i. The use of special exercising programs is recommended.
- j. Testing shall be performed according to a Test Plan, which shall be included in the test report.
- k. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

12. Testing Requirement and Procedure (DIP)

The test was based on IEC 61000-4-11 (1994)

12.1. Test Conditions

1. Source voltage and frequency: 230V / 50Hz, Single phase.

2. Test of interval: 10 sec.

3. Level and duration: Sequency of 3 dips/interrupts.

4. Voltage rise (and fall) time : 1 \sim 5 μ s.

5. Test severity:

Voltage dip and	Test Duration
Interrupt reduction (%)	(ms)
30	500
60	100
100	10
100	80
100	5000

12.2. Operating Condition

Full system

13. Notice for Class A Product

This Notice is for class A product only. If the Equipment under Test is a class B product, this notice should be disregarded.

Class A ITE is a category of all other ITE which satisfies the class A ITE limits but not the class B ITE limits. Such equipment should not be restricted in its sale but the following warning shall be included in the instructions for use:

Warning

This is a class A product. In a domestic environment this product may cause radio interference in which case the user may be required to take adequate measures.

14. Declaration of Conformity and the CE Mark

There are three possible procedures pertaining to the declaration of conformity:

- 14.1. Conformity Testing and Declaration of Conformity by the Manufacturer or His Authorized Representative Established within the Community or by an Importer.
 - Article 10 (1) of the EMC Directive, § 3 (1) no. 2a of the EMC Act.
- 14.2. Declaration of Conformity Issued by the Manufacturer or His Authorized Representative Established within the Community or by an Importer Following Testing of the Product and Issued of an EC certificate of conformity by a competent body.
 - Article 10 (2) of the EMC Directive, § 3 (1) no. 2b of the EMC Act.
- 14.3. Declaration of Conformity Issued by the Manufacturer or His Authorized Representative Established within the Community or by an Importer Following Testing and Certification of the Product by a Notified Body.
 - Article 10 (5) of the EMC Directive,
 - § 3 (1) no. 2b of the EMC Act (radio transmitting installations).

14.4. Specimen For The CE Marking Of Electrical / Electronical Equipment

The components of the CE marking shall have substantially the same vertical dimension, which may not be less than 5 mm.



15. Feature of Equipment under Test

The Wireless Router incorporates many advanced features, carefully designed to provide sophisticated functions while being easy to use.

15.1. History of this test report

The Model No. TEW-431BRP (Report No:CE03111004-A) is the same and it only differs from the outside cosmetic. The functions and specifications are the same.

16. Test Configuration of Equipment under Test

16.1. Test Mode

- The following test mode was performed for conduction test:
- Frequency range investigated: conduction 150 KHz to 30 MHz, radiation 30 MHz to 1000MHz.

16.2. Description of Test System

For Conducted Emission Test and Radiated Emission Test

Product	Manufacturer	Model No.	Serial No.	I/O Cable
Wireless	TRENDware	TEW-431BRP	N/A	Non-shielded, 1.2m
Broadband Router	IRENDWale	IEW-43 IBRP		Non-shielded, 2.5m
Printer	EPSON	Stylus photo 700	N/A	shielded, 1.2m
Notebook PC	Comood	Drogerio 2000	N/A	Non-shielded, 2.5m
Notebook PC	k PC Comoaq Presario 2800		IN/A	AC Power Cord

Remark "*" means equipment under test.

17. Test Software

During testing, "Ping.exe" under WIN 2000 was executed to link with the remote workstation to receive and transmit data by UTP cable.

18. General Information of Test

Test Site ELECTRONICS TESTING CENTER, Taiwan

No. 34, Lin 5, Ding Fu Tdun, Linkou Hsiang, Taipei, Taiwan, R.O.C.

Test Voltage : 230V/ 50Hz

EMI Test (conduction and radiation):

EN 301 489-1 V.1.4.1 (2002-08) EN 301 489-17 V.1.2.1 (2002-08)

Harmonics Test:

European Standard EN 61000-3-2.

Voltage Fluctuations Test:

European Standard EN 61000-3-3.

EMS Test:

Test in Compliance with : European Standard EN 301 489-1 V.1.4.1 (2002-08).

European Standard EN 301 489-17 V.1.2.1 (2002-08).

ESD: EN 61000-4-2, RS: EN 61000-4-3, EFT: EN 61000-4-4, SURGE: EN 61000-4-5,

CS: EN 61000-4-6, DIPS: EN 61000-4-11

Frequency Range

Radiated emission test: from 30 MHz to 1,000 MHz

Investigated

Radio frequency electromagnetic field immunity test: 80-1000 MHz,

1400-2000 MHz

The test distance of radiated emission test from antenna to EUT is

10 M

Test Distance

The test distance of radio frequency electromagnetic field immunity

test from antenna to EUT is 3 M.

18.1. Description of Major Test Instruments

(For Conducted)

Test Equipment	Calibration Date	Recommended Recal. Date
Shielded Room\ Riken\	N.C.R.	N.C.R.
EMI test receiver\R&S\ESCS30	Aug. 10, 2003	Aug. 09, 2004
L.I.S.N.\EMCO\ESH2-Z5	Sep. 22, 2003	Sep. 21, 2004
Monitor\IBM \E54	N.C.R.	N.C.R.
Printer\HP\LaserJet 1000	N.C.R.	N.C.R.
Computer\Acer\Veriton 7500g	N.C.R.	N.C.R.

(For Radiation)

Test Equipment	Calibration Date	Recommended Recal. Date
Amplifier Receiver\HP\8447D	Feb. 20, 2003	Feb. 19, 2004
Bilog Antenna\Chase\CBL6111C	Oct. 29, 2003	Oct. 28, 2004
Pre -selector\HP\85685A	Jan. 02, 2003	Jan. 01, 2004
Spectrum Analyzer\HP\8568B	Jan. 02, 2003	Jan. 01, 2004
Quasi-Peak Adaptor\HP\85650A	Jan. 02, 2003	Jan. 01, 2004

19. Test Result of AC Powerline Conducted Emission

19.1. Test Mode 1 (CH 01b @ 11Mbps Bit-Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

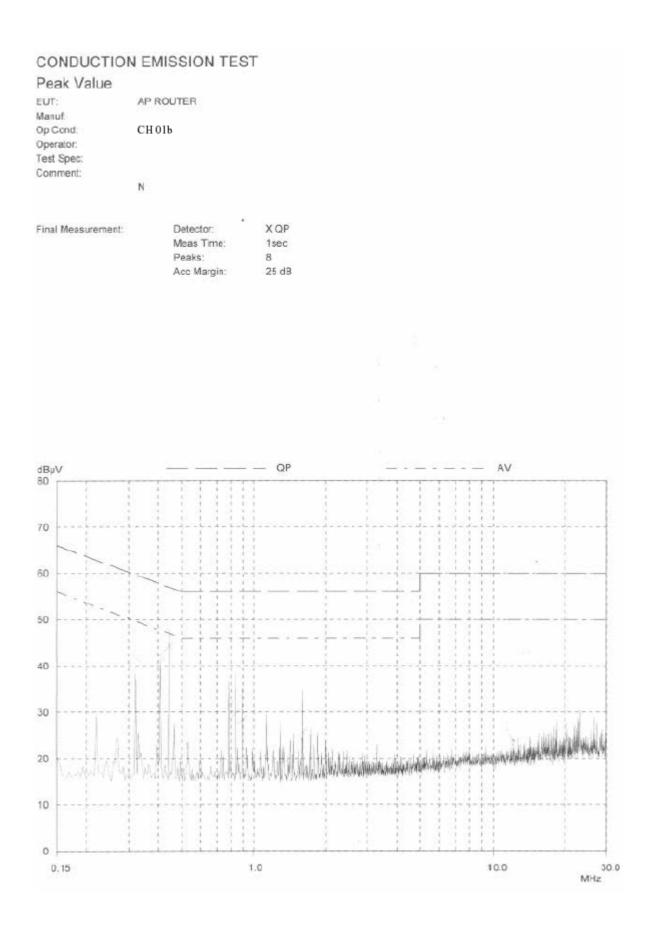
All emissions not reported here are more than 10 dB below the prescribed limit.

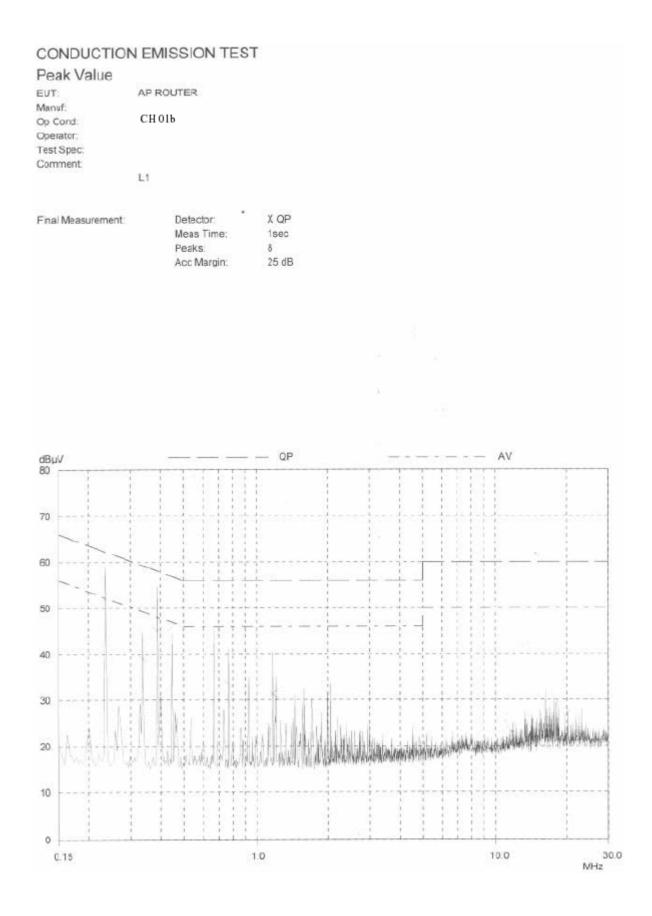
The test was passed at the minimum margin that marked under gray area in the following table

(802.11b)

Freq.	Meter Reading (dBuV)				Factor	F	Result	(dBu\	/)	Limit (dBuV)		Margins	(dB)
	Q.P \	√alue	AVG.	Value		Q.P \	√alue	AVG.	Value	Q.P	AVG.	Q.P	AVG.
(MHz)	Ν	L1	N	L1	(dB)	Ν	L1	N	L1	Value	Value	۷.۲	AVG.
0.322	41.8	51.7			0.3	42.1	52			59.7	49.7	-7.70	
0.408	42.2	39			0.3	42.5	39.3			57.7	47.7	-15.20	
0.443	44.2	45.2			0.3	44.5	45.5			57.7	47.0	-11.50	
0.785	31.6	46			0.3	31.9	46.3			56.0	46.0	-9.70	
0.84	29.8	33.5			0.3	30.1	33.8			56.0	46.0	-22.20	
0.895	28.4	31.4			0.3	28.7	31.7			56.0	46.0	-24.30	

- 1. The EUT was placed 0.8m above reference ground plane.
- 2. The symbol of "---" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 3. The expanded uncertainty of the conducted emission tests is 2.45 dB.





19.1.1 Test Mode 2 (CH 07b @ 11Mbps Bit-Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

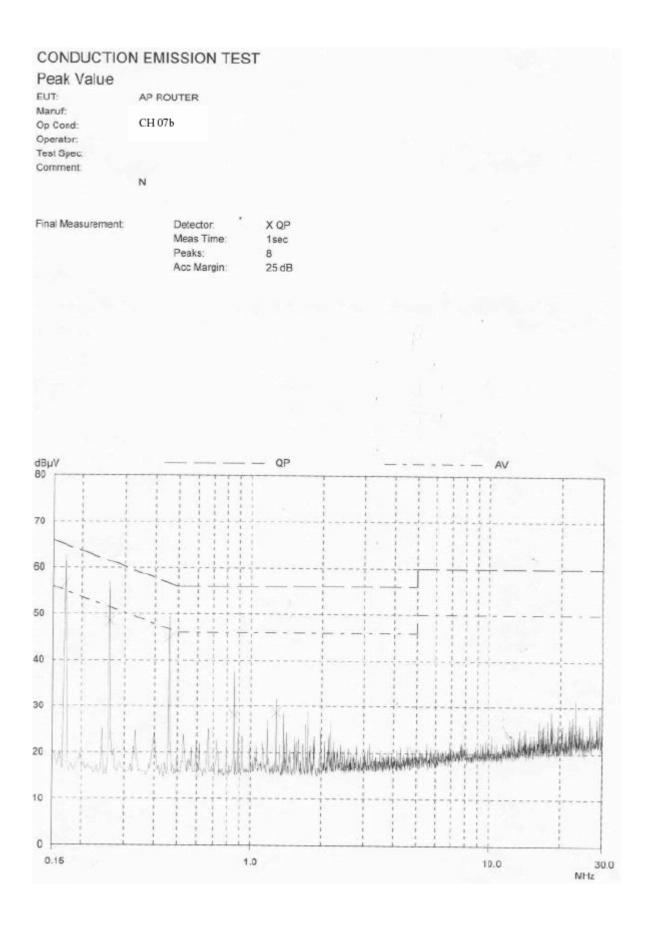
Test Set-up: Table-top Equipment

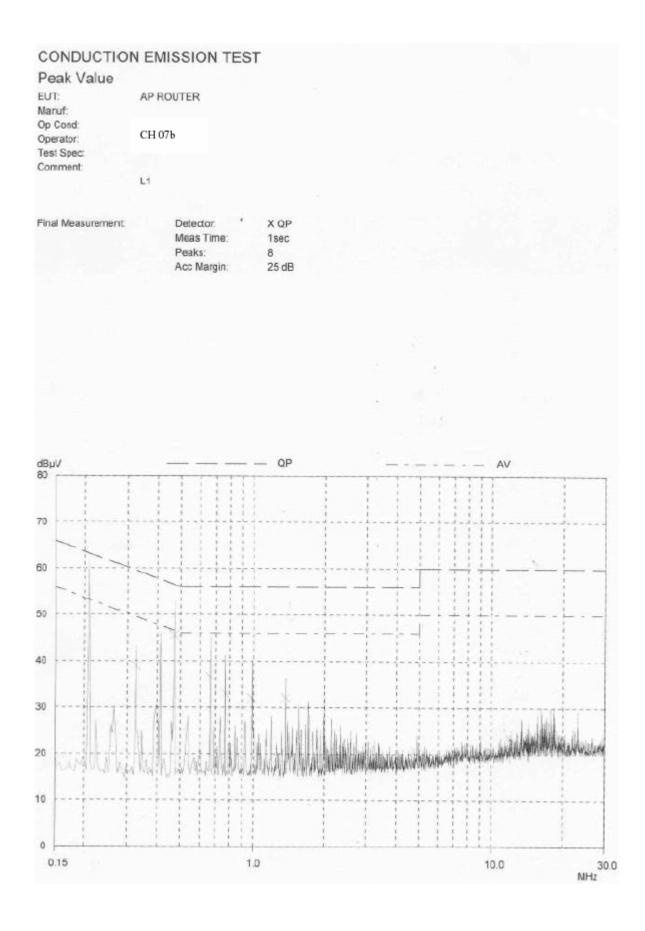
All emissions not reported here are more than 10 dB below the prescribed limit.

The test was passed at the minimum margin that marked under gray area in the following table

Freq.	Meter Reading (dBuV)				Factor	F	Result	(dBu\	')	Limit (dBuV)		Margins (dB)	
	Q.P Value AVG. Value				Q.P \	√alue	AVG.	Value	Q.P	AVG.	Q.P	AVG.	
(MHz)	N	L1	N	L1	(dB)	N	L1	N	L1	Value	Value	۱. ک	AVG.
0.17	56.6	54.1	25.5	23.4	0.2	56.8	54.3	25.7	23.6	65.0	55.0	-8.2	-29.3
0.259	48.5	38.9	21.4	19.9	0.2	48.7	39.1	21.6	20.1	61.5	51.5	-12.7	-29.8
0.459	44.9	46	19.2	22	0.3	45.2	45.3	19.5	22.3	56.7	46.7	-10.4	-24.4
0.855	28.2	33	14.2	10.8	0.3	28.5	33.3	14.5	11.1	56.0	46.0	-22.7	-31.5
1.281	28.7	32	14.7	14.2	0.4	29.1	32.4	15.1	14.6	56.0	46.0	-23.6	-30.9
1.754	19.8	32.1	9.4	10.7	0.5	20.3	32.6	9.9	11.2	56.0	46.0	-23.4	-34.8

- 1. The EUT was placed 0.8m above reference ground plane.
- 2. The symbol of "---" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 3. The expanded uncertainty of the conducted emission tests is 2.45 dB.





19.1.2 Test Mode 3 (CH 13b@ 11Mbps Bit-Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

All emissions not reported here are more than 10 dB below the prescribed limit.

The test was passed at the minimum margin that marked under gray area in the following table

Freq.	Meter Reading (dBuV)				Factor	F	Result	(dBu\	')	Lir (dB	mit uV)	Margins	(dB)
	Q.P	Value	AVG.	Value		Q.P \	√alue	AVG.	Value	Q.P	AVG.	Q.P	AVG.
(MHz)	N	L1	N	L1	(dB)	Ν	L1	N	L1	Value	Value	۷.۲	AVG.
0.373	46	53.3		22.6	0.3	46.3	53.6		22.9	58.4	48.4	-4.9	-25.6
0.539	38.2	45.2		21.8	0.3	38.5	45.5		22.1	56.0	46.0	-10.5	-23.9
0.609	35.5	47.5		17.7	0.3	35.8	47.8		18	56.0	46.0	-8.2	-28
0.789	29.9	42.9		21.3	0.3	30.2	43.2		21.6	56.0	46.0	-12.8	-24.4
1.004	31.4	34.7		11.7	0.3	31.7	35		12	56.0	46.0	-21.0	-34
1.07	32.1	33.4		10.9	0.3	32.4	33.7		11.2	56.0	46.0	-22.3	-34.8

- 1. The EUT was placed 0.8m above reference ground plane.
- 2. The symbol of "---" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 3. The expanded uncertainty of the conducted emission tests is 2.45 dB.

CONDUCTION EMISSION TEST

Peak Value

EUT:

AP ROUTER

Manuf:

Op Cond:

CH 13b

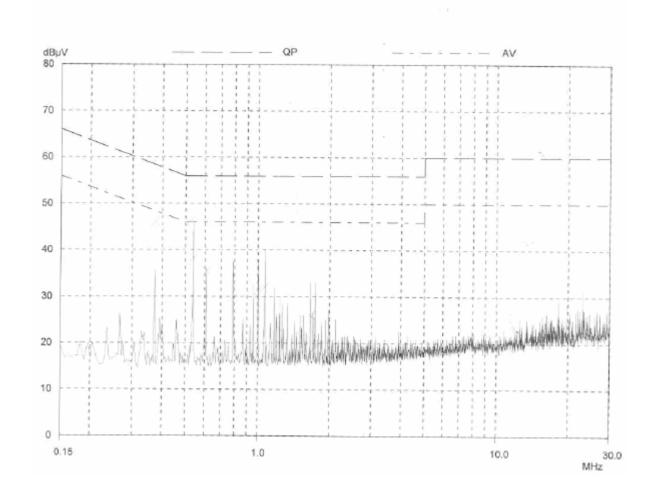
Operator: Test Spec Comment

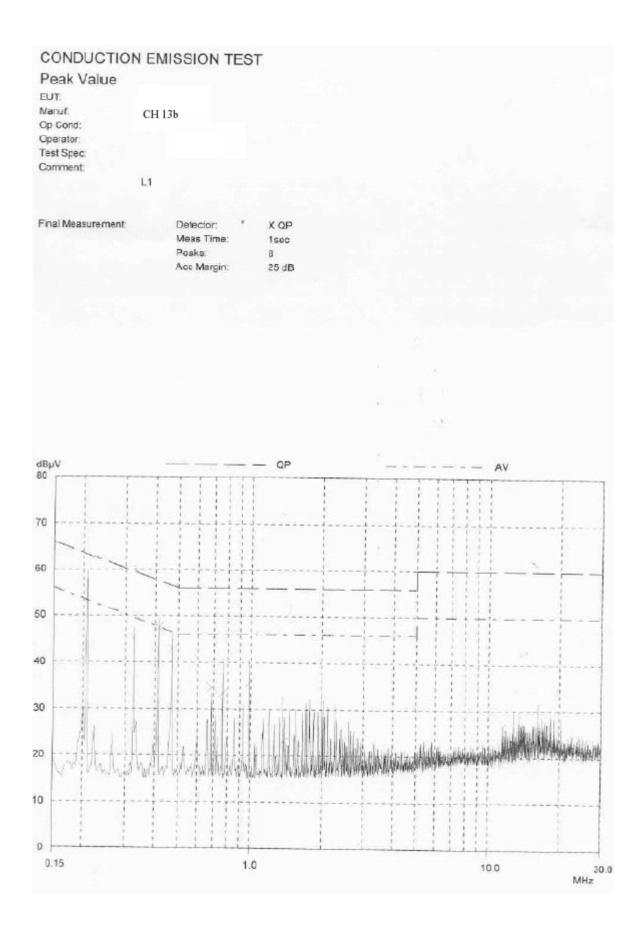
N

Final Measurement:

Detector: X QP Meas Time: 1sec

Peaks: Acc Margin: 8 25 dB





19.1.3 Test Mode 4 (CH 01g@ 54Mbps Bit-Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

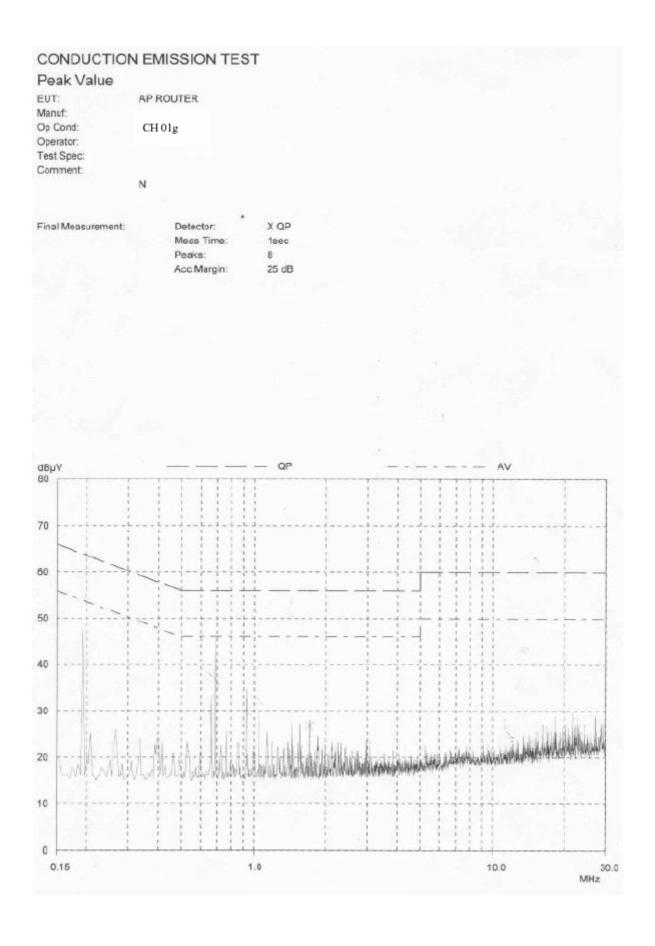
All emissions not reported here are more than 10 dB below the prescribed limit.

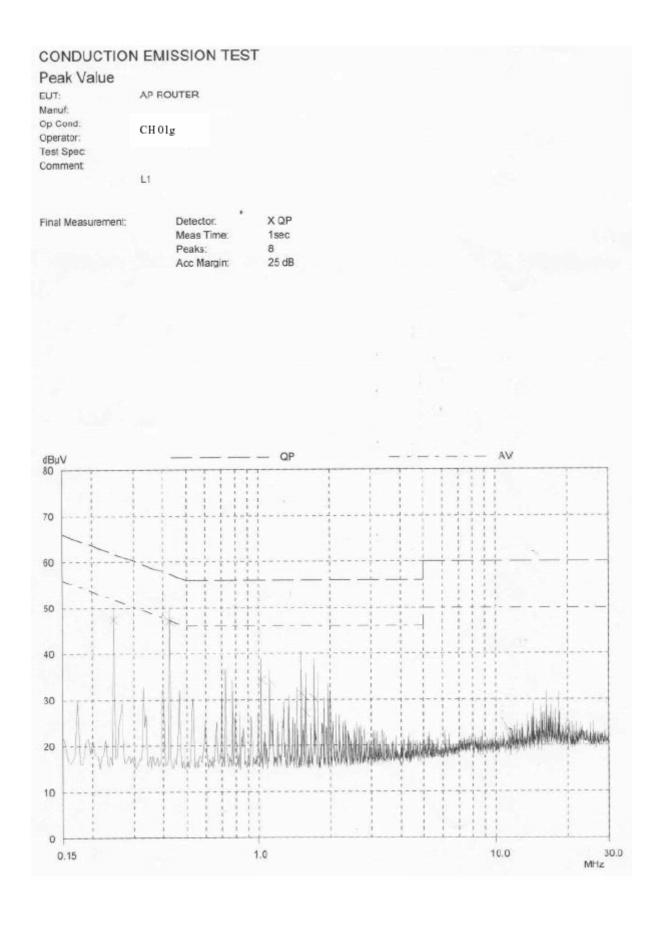
The test was passed at the minimum margin that marked under gray area in the following table

802.11g

Freq.	Meter Reading (dBuV)				Factor	F	Result	(dBuV	')	Limit (dBuV)		Margins	(dB)
	Q.P Value AVG. Value				Q.P \	/alue	AVG.	Value	Q.P	AVG.	Q.P	AVG.	
(MHz)	Ν	L1	N	L1	(dB)	N	L1	N	L1	Value	Value	۷.۲	AVG.
0.193	54.7	47.5	24.6		0.2	54.9	47.7	24.8		63.9	53.9	-9.0	-29.1
0.664	37.6	47.1	18.1		0.3	37.9	47.4	18.4		56.0	46.0	-8.6	-27.6
0.688	36.8	36.1	12.3		0.3	37.1	36.4	12.6		56.0	46.0	-18.9	-33.4
0.934	29.9	34.2	17.1		0.3	30.2	34.5	17.4		56.0	46.0	-21.5	-28.6
1.065	32.3	34.2	11.1		0.3	32.6	34.5	11.4		56.0	46.0	-21.5	-34.6
1.703	26.8	30.3	22.4		0.4	27.2	30.7	22.8		56.0	46.0	-25.3	-23.2

- 1. The EUT was placed 0.8m above reference ground plane.
- 2. The symbol of "---" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 3. The expanded uncertainty of the conducted emission tests is 2.45 dB.





19.1.4 Test Mode 5 (CH 07g @ 54Mbps Bit - Rate)

Relative Humidity: 70 %

Temperature: 24°CTest Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

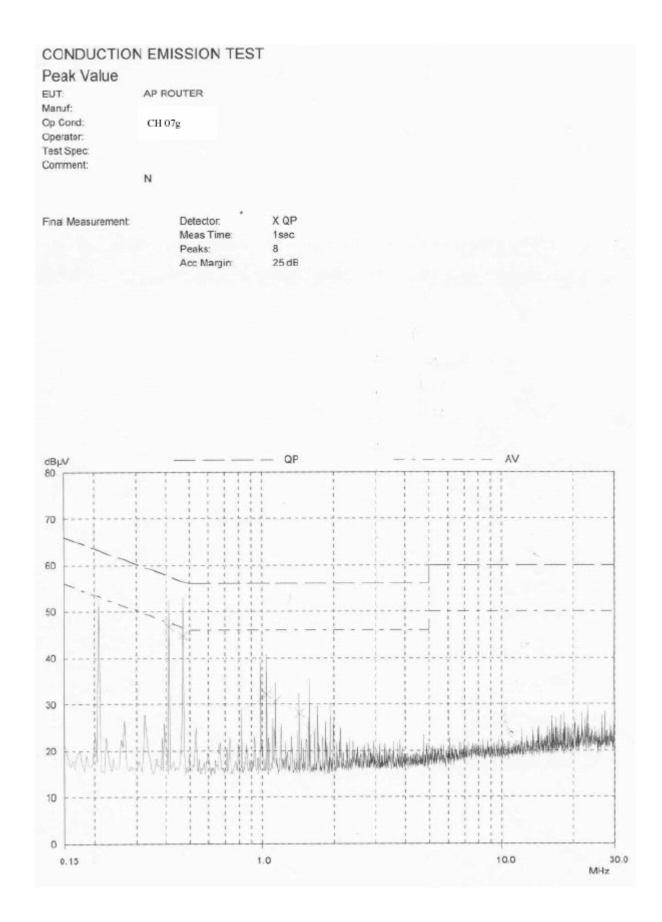
All emissions not reported here are more than 10 dB below the prescribed limit.

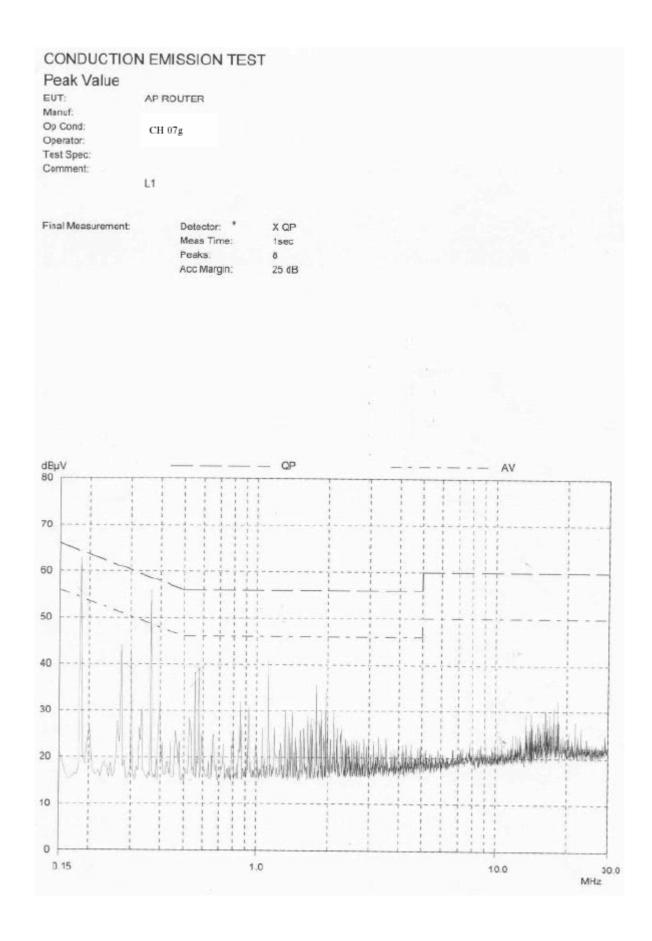
The test was passed at the minimum margin that marked under gray area in the following table

Freq.	N		Readin uV)	g	Factor	Factor			Result (dBuV)			Margins	(dB)
	Q.P \	Value	AVG.	Value	1	Q.P \	√alue	AVG.	Value	Q.P	AVG.	Q.P	AVG.
(MHz)	N	L1	N	L1	(dB)	N	L1	N	L1	Value	Value	۷.۲	AVG.
0.209	53.3	55.6	22.6	25.1	0.2	53.5	55.8	22.8	25.3	63.3	53.3	-7.7	-28
0.412	46.7	43.7	18.1	16.1	0.3	47	44	18.4	16.4	57.6	47.6	-10.6	-29.2
0.47	44.7	38.8	19	14.5	0.3	45	39.1	19.3	14.8	56.5	46.5	-11.5	-27.2
0.988	31.4	47.4	13	17.6	0.3	31.7	47.7	13.3	18.9	56.0	46.0	-8.3	-28.1
1.043	32.1	36	11.2	12.3	0.3	32.4	36.3	11.5	12.6	56.0	46.0	-19.7	-33.4
1.141	30.7	38.8	15.1	12.3	0.3	31	39.1	15.4	12.6	56.0	46.0	-16.9	-30.6

Notes:

- 1. The EUT was placed 0.8m above reference ground plane.
- 2. The symbol of "---" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 3. The expanded uncertainty of the conducted emission tests is 2.45 dB.





19.1.5 Test Mode 6 (CH 13g@ 54Mbps Bit - Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

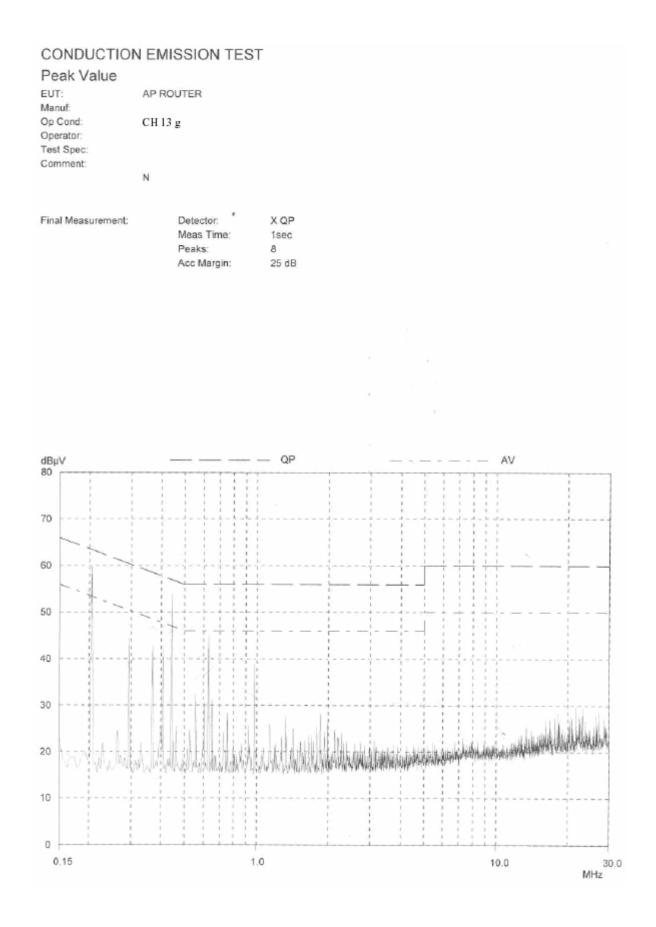
• All emissions not reported here are more than 10 dB below the prescribed limit.

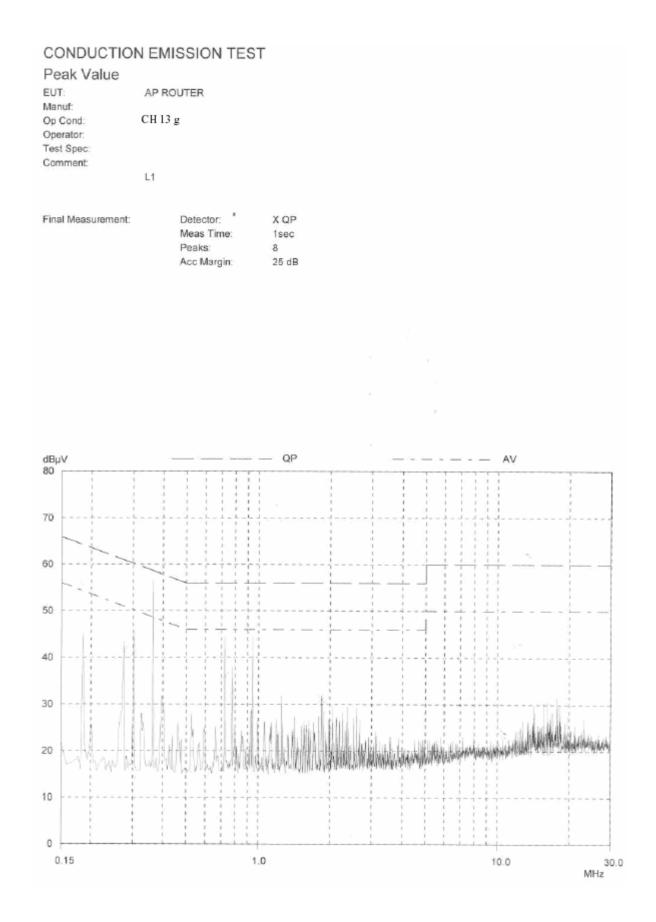
The test was passed at the minimum margin that marked under gray area in the following table

Freq.	N		Readin uV)	eading uV) Factor		F	Result (dBuV)		Limit (dBuV)		Margins	(dB)	
	Q.P \	√alue	AVG.	Value	1	Q.P \	√alue	AVG.	Value	Q.P	AVG.	Q.P	AVG.
(MHz)	N	L1	N	L1	(dB)	N	L1	N	L1	Value	Value	۷.۲	AVG.
0.205	53.7	55.5	22.9	24.9	0.2	53.9	55.7	23.1	25.1	63.4	53.4	-7.7	-28.3
0.295	38.9	41.5	13.5	14.7	0.2	39.1	41.7	13.7	14.9	60.4	50.4	-18.6	-35.4
0.369	46.8	40.8	17	15.1	0.3	47.1	41.1	17.3	15.4	58.5	48.5	-11.4	-31.2
0.408	47.1	48.2	18.7	18	0.3	47.4	48.5	19	18.3	57.7	47.7	-9.2	-28.7
0.443	46	36	17.2	15.8	0.3	46.3	36.3	17.5	16.1	57.0	47.0	-10.7	-29.5
0.559	35.7	32.4	12.3	10.8	0.3	36	32.7	12.6	11.1	56.0	46.0	-20.0	-33.4

Notes:

- 1. The EUT was placed 0.8m above reference ground plane.
- 2. The symbol of "---" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 3. The expanded uncertainty of the conducted emission tests is 2.45 dB.



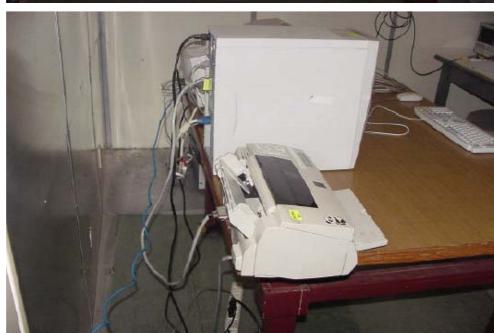


19.2. Photographs of Conducted Powerline Test Configuration

• The photographs show the configuration that generates the maximum emission.



FRONT VIEW



REAR VIEW

20. Test Result of Radiated Emission

20.1. Test Mode 1 (TX / RX @ 11Mbps Bit – Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

All emissions not reported here are more than 10 dB below the prescribed limit.

The test was passed at the minimum margin that marked under gray area in the following table

(802.11b)

Emission	Meter Reading		CORR'd	Res	sults	Limit	Margins
frequency	(dBuV)		Factor	(dBuV/m)		(10m)	(dB)
(MHz)	HOR.	VERT.	(dB)	HOR.	VERT.	(dBuV/m)	(ub)
34.619	35.9	36.1	-11.4	24.5	24.7	30	-5.3
106.481	36.7	37.2	-12.9	23.8	24.3	30	-5.7
163.992	35.4	37.3	-13.5	21.9	23.8	30	-6.2
173.408	38.4	39	-13.8	24.6	25.2	30	-4.8
212.525	39	39.4	-13.3	25.7	26.1	30	-3.9
256.773	40	41.2	-9.5	30.5	31.7	37	-5.3

Notes:

1. Measurement Distance: 10m

2. Height of table on which the EUT was placed: 0.8m

3. Height of Receiving Antenna: 1 - 4m

4. Remark "---" means that the emissions level is too low to be measured.

5. The expanded uncertainty of the radiated emission tests is 3.53 dB.

20.1.1 Test Mode 2 (TX / RX @ 54Mbps Bit - Rate)

Relative Humidity: 70 %

Temperature: 24°C

Test Date: Nov. 28, 2003

Power Supply System: AC Power: 230Vac 50Hz

Test Set-up: Table-top Equipment

All emissions not reported here are more than 10 dB below the prescribed limit.

The test was passed at the minimum margin that marked under gray area in the following table

(802.11g)

Emission	Meter Reading		CORR'd	Res	sults	Limit	Margins
frequency	(dBuV)		Factor	(dBuV/m)		(10m)	(dB)
(MHz)	HOR.	VERT.	(dB)	HOR.	VERT.	(dBuV/m)	(ub)
47.696	41.1	42.4	-17.7	23.4	24.7	30	-5.3
105.711	37.8	37.6	-13.1	24.7	24.5	30	-5.3
158.964	39.1	38.1	-13.3	25.8	24.8	30	-4.2
190.401	40.3	39.8	-13.9	26.4	25.9	30	-3.6
256.748	36.8	37.6	-9.5	27.3	28.1	37	-8.9
271.636	39.7	40.7	-10.3	29.4	30.4	37	-6.6

Notes:

1. Measurement Distance: 10m

2. Height of table on which the EUT was placed: 0.8m

3. Height of Receiving Antenna: 1 - 4m

4. Remark "---" means that the emissions level is too low to be measured.

5. The expanded uncertainty of the radiated emission tests is 3.53 dB.

20.2. Photographs of Radiated Emission Test Configuration

• The photographs show the configuration that generates the maximum emission.



FRONT VIEW



REAR VIEW

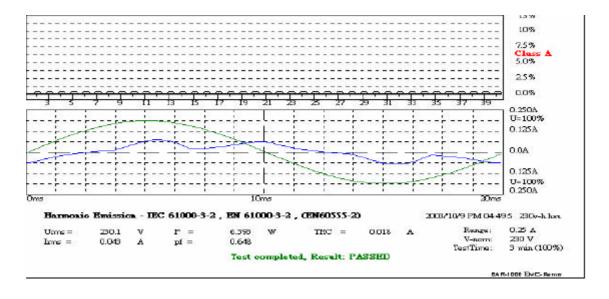
21. Harmonics Test

Basic Standard: EN 61000-3-2:1995/A1/A2:1998/A14:2000

AC Power : 230Vac 50Hz Temperature : 25

Test Data: Nov. 28, 2003 Relative Humidity: 50 % RH

Urms = 23	30.1V Freq =	49.984 Ran	ge: 0.25A	Irms = 0.043A lpk = 0.075A cf = 1.749						
P = 6.393W	Pap = 9.859\	/A pf = 0.64	8	THDi = 43.00% THDu = 0.10% Calss A						
	Test-Time: 3r	min (100%)		Te	st completed I	Result: PASS	ED			
Order	Freq. (Hz)	Imax (A)	Limit (A)	Order	Freq. (Hz)	Imax (A)	Limit (A)			
1	50	0.121		21	1050	0.0002	0.1071			
2	100	0.0005	1.08	22	1100	0	0.0836			
3	150	0.0133	2.3	23	1150	0.0003	0.0978			
4	200	0.0002	0.43	24	1200	0	0.0767			
5	250	0.0127	1.14	25	1250	0.0002	0.09			
6	300	0.0001	0.3	26	1300	0	0.0708			
7	350	0.0024	0.77	27	1350	0.0002	0.0833			
8	400	0.0001	0.23	28	1400	0	0.0657			
9	450	0.0015	0.4	29	1450	0.0002	0.0766			
10	500	0	0.184	30	1500	0	0.0613			
11	550	0.0016	0.33	31	1550	0.0001	0.0726			
12	600	0	0.1533	32	1600	0	0.0575			
13	650	0.0008	0.21	33	1650	0.0001	0.0682			
14	700	0	0.1314	34	1700	0	0.0541			
15	750	0.0005	0.15	35	1750	0.0001	0.0643			
16	800	0	0.115	36	1800	0	0.0511			
17	850	0.0005	0.1324	37	1850	0.0001	0.0608			
18	900	0	0.1022	38	1900	0	0.0484			
19	950	0.0003	0.1184	39	1950	0.0001	0.0577			
20	1000	0	0.092	40	2000	0	0.046			



22. Voltage Fluctuations Test

• Basic Standard : EN 61000-3-3:1995/A1:1998

• FINAL TEST RESULT : **PASS** • Temperature : 25

Test Data : Nov. 28, 2003
 Relative Humidity : 50 % RH

	Pst	Plt	Dc (%)	Dmax (%)	Dt (%)
Reading	0.070	0.070	0.00	0.00	0.00
Limit	0.65	1.0	3.0	4.0	3.0

22.1. TEST EQUIPMENT SETTINGS

Line Voltage: 230 V
 Test Duration: 00:10:00 minutes

• Line Frequency: 50 Hz • Measurement Delay: 10.0 seconds

Pst Integration Periods : 1
 Pst Integration Time : 10 minutes

22.2. Photographs of Harmonics test, Voltage Fluctuation and Flicker test



Harmonics test



Flicker test

23. Electrostatic Discharge Immunity Test (ESD)

Final Test Result : PASS

Pass performance Criteria : TT/TR
Required performance criteria : TT/TR

Basic Standard : EN 61000-4-2:1995/A1:1998/A2:2000

Product Standard EN 301 489-17

Level : 3 for air discharge,

2 for contact discharge

Test Voltage : $\pm 2 / \pm 4 / \pm 8$ KV for air discharge,

±2 / ±4 KV for contact discharge

Temperature : 25 °C

Relative Humidity : 60%

Test Date : Nov. 28, 2003

Observation : Normal

23.1. Test Severity Levels

	Contact Discharge		Air Discharge					
Level	Test Voltage (KV) of	Level	Test Voltage (KV) of					
	Contact discharge		Air Discharge					
1	±2	1	±2					
2	±4	2	±4					
3	±6	3	±8					
4	±8	4	±15					
Х	Specified	Х	Specified					
	Remark: "X" is an open level.							

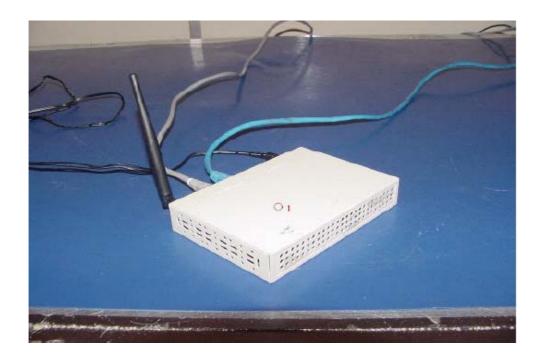
23.2. Test Result of Air Discharge/ Contact Discharge

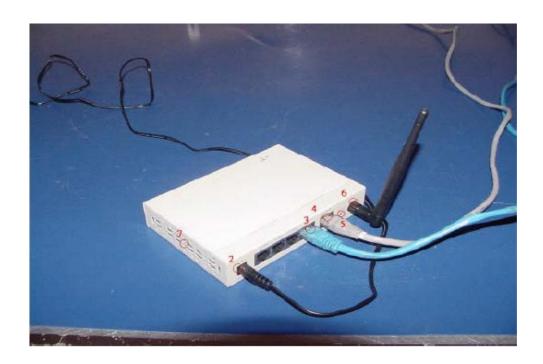
Energy-Storage Capacito	nergy-Storage Capacitor: 150 pF Contact Discharge Times: 10 times/each condition															
Discharge Resistor	Discharge Resistor : 330 Ω Air Discharge Times : 10 times/each condition															
\Discharge Mode		Contact Discharge					Air Discharge									
\ESD Voltage	2	_ KV	4	_ KV		_ KV		_ KV	2	_ KV	4	_ KV	8	_ KV		_ KV
\Points \Result \Polarity	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-
VCP	N	N	N	N												
HCP	N	N	N	N												
P ₁ ~P ₇									N	Ν	N	N	N	N		
P ₈	N	N	N	N												

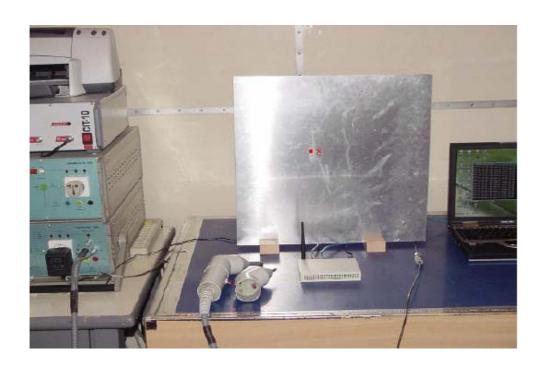
Note: "N" means the EUT function was correct during the test.

[&]quot; --- "means the test could not be carrier out.

23.3. Photographs of Electrostatic Discharge Immunity Test







24. Radio Frequency Electromagnetic Field Immunity Test (RS)

Final Test Result : PASS

Pass performance Criteria : CT/CR
Required performance criteria : CT/CR

Basic Standard : EN 61000-4-3:1996/A1:1998/A2:2000

Product Standard EN 301 489-17

Level : 2

Frequency Range : 80-1000 MHz; 1400-2000 MHz

Field Strength : 3 V/m (Modulated 80% AM)

Temperature : 26 °C

Relative Humidity : 65 %

Test Date : Nov. 28, 2003

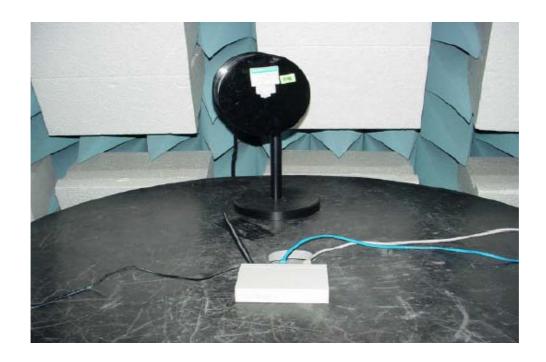
Observation : Normal

24.1. Test Severity Levels

Frequency F	Range (MHz)	Test Axis	Polarization of Device	Test Result
80~1000	1400~2000	x- axis	Vertical	N
80~1000	1400~2000	y- axis	Vertical	N
80~1000	1400~2000	z- axis	Vertical	N

Note: " N " means the EUT function was correct during the test.

24.2. Photographs of Radio Frequency Electromagnetic Field Immunity Test



25. Electrical Fast Transient/Burst Immunity Test (EFT/BURST)

Final Test Result : PASS

Pass performance Criteria : CT/CR Required performance criteria : TT/TR

Basic Standard : EN61000-4-4:1995/A1:200

Product Standard EN 301 489-17

Level : 2

Test Voltage : on Power Supply -- ±1.0 KV

on I/O signal, data and control line -- ±0.5 KV

Temperature : 25 °C

Relative Humidity : 60 %

Test Date : Nov. 28, 2003

Observation : Normal

25.1. Test Severity Levels

\Voltage\Pola	arity	0.5	kV	1.0 kV		
\Test Point\Mode\Result		+	-	+	-	
	L	N	N	N	N	
Power Line	N	N	N	N	N	
	L-N	N	N	N	N	
LAN Line		N	N			

Note: "N" means the EUT function was correct during the test.

[&]quot;---"means the test could not be carrier out.

25.2. Photographs of Electrical Fast Transient/BURST Immunity Test





26. Surge Immunity Test

FINAL TEST RESULT : PASS

Pass performance Criteria : CT/CR

Required performance criteria: TT/TR

Basic Standard : EN 61000-4-5 :1995/A1:2000

Product Standard EN 301 489-17

Surge wave form (Tr/Th) : 1, 2/50 (8/20) μs

Level : on Signal ports And Telecommunication – N/A

on Input AC Power Port -- 2

Test Voltage : on Signal ports And Telecommunication – N/A

on Input AC Power Port -- ±1.0 KV

Temperature : 25 °C

Relative Humidity : 60 %

Test Date : Nov. 28, 2003

Remark : " N " means the EUT function was correct during the test.

Angle ☑ 0° ☑ 90° ☑ 180° ☑ 270° ☑ 360°

Voltage (KV): 0.5 kV Test Location: L-N Test Result: PASS

26.1. TEST LEVEL

\Phase \Volta	age \Mode \Po	larity \Result	0°	90°	180°	270°	360°
0.5 kV	L-N	+	N	N	N	N	N
0.5 KV	L-IN	-	N	N	N	N	N

Note: "N" means the EUT function was correct during the test.

26.2. Photographs of Surge Immunity Test



27. Conducted Disturbances Induced by Radio-Frequency Field Immunity Test (CS)

Final Test Result : PASS

Pass performance Criteria : CT/CR

Required performance criteria: CT/CR

Basic Standard : EN 61000-4-6 :1996/A1:2000

Product Standard EN 301 489-17

Level : 2

Test Voltage 3 V rms (Modulated, 1KHz, 80%, AM)

Frequency Range 0.15 MHz to 80 MHz

Dwell time 2.9 seconds

Frequency step size 1 %

Coupling mode CDN-M2 for AC power ports, Clamp for Signal Ports

Temperature : 25 °C
Relative Humidity : 50 %

Test Date : Nov. 28, 2003

Observation : Normal

27.1.**TEST LEVEL**

Frequency Range (MHz)	Tested Line	Test Result
0.15~80	Power Line	N
0.15~80	LAN Line	N

Note: "N" means the EUT function was correct during the test.

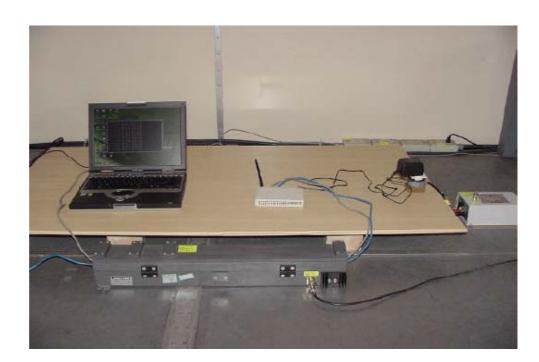
27.2. OPERATING CONDITION

Full system

27.3. Photographs of CS Tests



Power Line



LAN Line

28. Voltage Dips and Voltage Interruptions Immunity Tests

Final Test Result : PASS

Pass performance Criteria TT/TR for voltage interruption, CT/CR and TT/TR for voltage dips

Required performance criteria TT/TR for voltage interruption, TT/TR for voltage dips

Basic Standard : EN 61000-4-11:1994/A4:2000

Product Standard EN 301 489-17

Temperature : 25 °C

Relative Humidity : 50 %

Test Date : Nov. 28, 2003

28.1. **TEST LEVEL**

TEST RECORD OF VOLTAGE INTERRUPTION/ DIPS

Test mod	Voltage dips	Durations (period / ms)	Interval(s)	Times	Phase	Result
Voltage interruptions	100%	5000	10	12	0°/180°	В
	60%	100	10	12	0°/180°	N
Voltage dips in %U _T	30%	10	10	12	0°/180°	N

Note: "N" means the EUT function was correct during test.

"B" means the EUT's function was fail during the test, the EUT operate as intended without operator intervention.

EMS Test Engineer: Kevin Lee

28.2. Photographs of Voltage Dips and Voltage Interruptions Immunity Tests



29. List of Measuring Equipment Used

(EMS)

Toot Fautisment	Calibration Date	Recommended	
Test Equipment	Calibration Date	Recal. Date	
EMC Emission Tester EMC-Partner Harnmonics-1000	Sep.06,2003	Sep.05,2004	
EMC Immunity tester\EMC-Partener\TRANSIENT-1000	Oct.17,2003	Oct.16,2004	
Metering Unit & Probe\EMCO\7122	Oct.30,2003	Oct.29,2004	
SMGL Generator\Agilent\83640B	Jun.23,2003	Jun.22,2004	
Amplifier\ar\50S1G4AM1	Jun.23,2003	Jun,22,2004	
Test System : FRANKONIA EMV-Mess-System GmbH\CIT-10	Feb.18,2003	Feb.17,2004	
CDN: FRANKONIA EMV-Mess-System GmbH\CDN M2+M3	Jul.17,2003	Jul.16,2004	
EM-Clamp : Schaffner\KEMZ801	Feb.09,2003	Feb.08,2004	